

MOS FIELD EFFECT TRANSISTOR μ PA1870

N-CHANNEL MOS FIELD EFFECT TRANSISTOR FOR SWITCHING



DESCRIPTION

The μ PA1870 is a switching device which can be driven directly by a 2.5-V power source.

The μ PA1870 features a low on-state resistance and excellent switching characteristics, and is suitable for applications such as power switch of portable machine and so on.

FEATURES

- Can be driven by a 2.5-V power source
- · Low on-state resistance

RDS(on)1 = 20.0 m Ω MAX. (Vgs = 4.5 V, ID = 3.0 A)

 $R_{DS(on)2} = 21.0 \text{ m}\Omega \text{ MAX.} \text{ (Vgs} = 4.0 \text{ V, Ip} = 3.0 \text{ A)}$

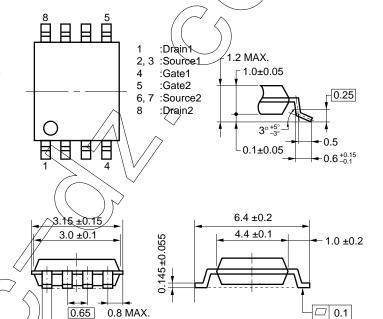
RDS(on)3 = 27.0 m Ω MAX. (VGS = 2.5 V, ID = 3.0 A)

· Built-in G-S protection diode against ESD

ORDERING INFORMATION

PART NUMBER	PACKAGE
μ PA1870GR-9JG	Power TSSOP8

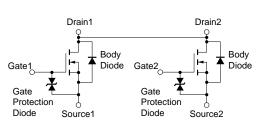
PACKAGE DRAWING (Unit: mm)





		~1 /	
Drain to Source Voltage	VDSS	20	V
Gate to Source Voltage	Vgss	±12	V
Drain Current (DC)	ID(DC)	±6.0	Α
Drain Current (pulse) Note 1	ID(pulse)	±80	Α
Total Power Dissipation Note 2	₽⊤	2.0	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	-55 to +150	°C

EQUIVALENT CIRCUIT



Notes 1. PW $\leq 10^{\circ} \mu s$, Duty Cycle $\leq 1\%$

2. Mounted on ceramic substrate of 50 cm² x 1.1 mm

Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

0.65

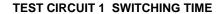
0.27^{+0.03}_{-0.08} \oplus 0.10 M

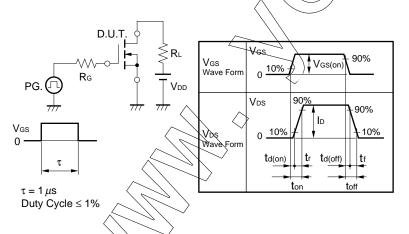
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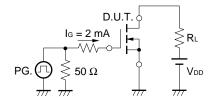
ELECTRICAL CHARACTERISTICS (TA = 25°C)

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 20 V, V _{GS} = 0 V			10	μΑ
Gate Leakage Current	Igss	Vgs = ±12 V, Vps = 0 V			±10	μΑ
Gate Cut-off Voltage	V _{GS(off)}	V _{DS} = 10 V, I _D = 1 mA	0.5	1.0	1.5	V
Forward Transfer Admittance	yfs	V _{DS} = 10 V, I _D = 3.0 A	5			S
Drain to Source On-state Resistance	RDS(on)1	Vgs = 4.5 V, ID = 3.0 A	12.0	15.0	20.0	mΩ
	RDS(on)2	Vgs = 4.0 V, lb = 3.0 A	13.0	15.5	21.0	$\supset_{m\Omega}$
	RDS(on)3	Vgs = 2.5 V, lb = 3.0 A	15.0	20.8	27.0	mΩ
Input Capacitance	Ciss	Vps = 10 V	/	900		pF
Output Capacitance	Coss	Vgs = 0 V		295)	pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		170	/	pF
Turn-on Delay Time	td(on)	V _{DD} = 10 V, I _D = 3.0 A		55		ns
Rise Time	tr	V _{GS(on)} = 4.0 V		210		ns
Turn-off Delay Time	td(off)	$R_G = 10 \Omega$	\Diamond	300		ns
Fall Time	t _f		\nearrow	340		ns
Total Gate Charge	QG	VDD = 16 V		10		nC
Gate to Source Charge	Qgs	Vgs = 4.0 V	7	2		nC
Gate to Drain Charge	Q _{GD}	ID = 6.0 A		6		nC
Body Diode Forward Voltage	V _{F(S-D)}	IF = 6.0 A, VGS = 0 V		0.80		V
Reverse Recovery Time	trr	IF = 6.0 A, VGS = 0 V		400		ns
Reverse Recovery Charge	Qrr	$di/dt = 50 A/\mu s$		1000		nC

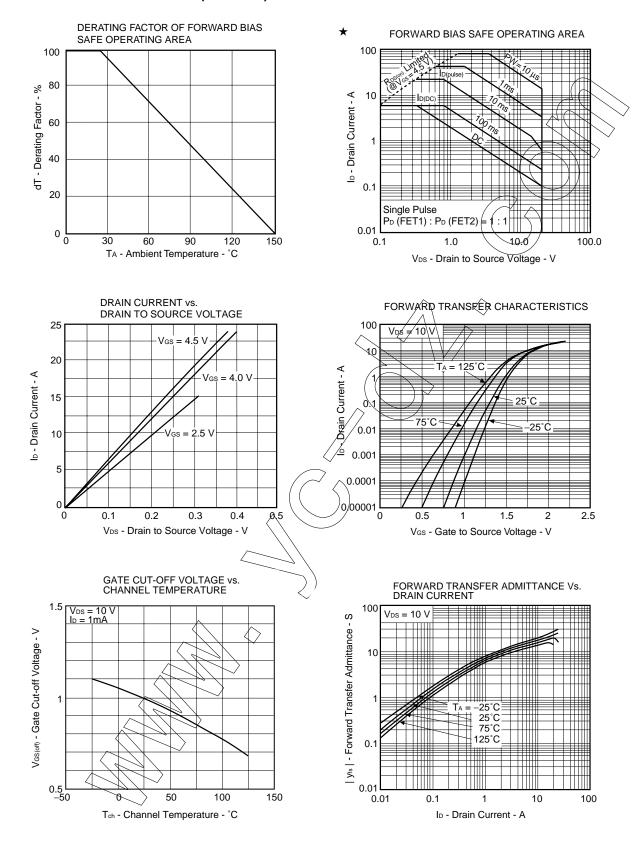




TEST CIRCUIT 2 GATE CHARGE

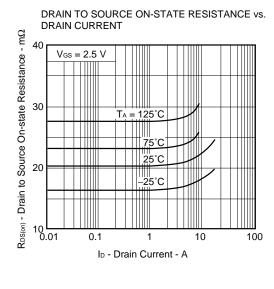


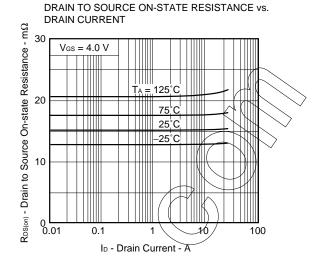
TYPICAL CHARACTERISTICS (TA = 25°C)

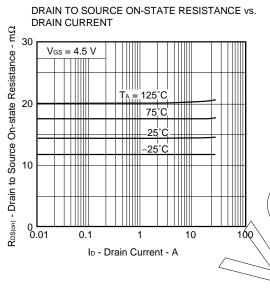


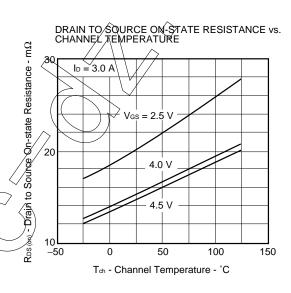
Data Sheet G14886EJ2V0DS

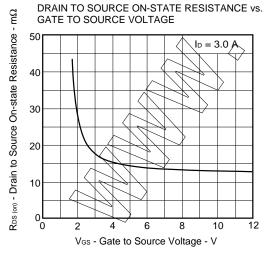
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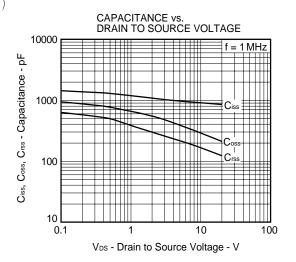


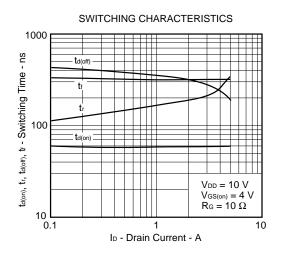




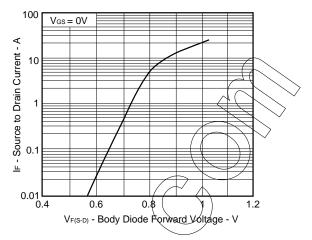


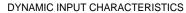


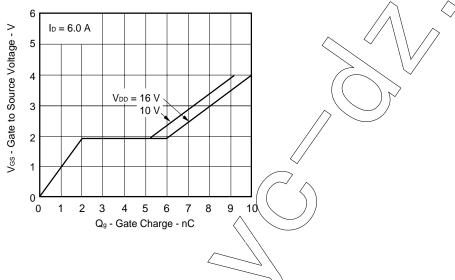




SOURCE TO DRAIN DIODE FORWARD VOLTAGE







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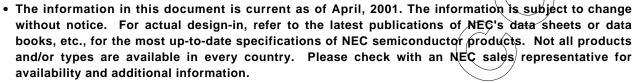
TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH 1000 1000 Single Pulse Mounted on Ceramic Board of 50 cm² x 1.1 mm Pb(FET1): Pb(FET2) = 1:1 1 m 10 m 100 m 1 10 100 1000 PW - Pulse Width - s

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